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J&R-0694

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Laurance A. Greenberg

Data

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applic. No.

09/922,479

Conf. No.: 7212

Applicant

Thomas Zettler

Filed

August 3, 2001

Art Unit

2117

Examiner

Phung My Chung

Title

Method and Device for Testing an Integrated Circuit,

Integrated Circuit to be Tested, and Wafer with a Large Number of Integrated Circuits to be Tested

Docket No.

J&R-0694 :

Customer No.

24131

## AMENDMENT

Hon. Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

#### Sir:

Responsive to the Office Action dated November 1, 2007 kindly amend the above-identified application as follows:

Amendments to the Specification begin on page 2 of this paper.

Amendments to the Claims are reflected in the listing of claims which begins on page 4 of this paper.

Amendments to the Drawings begin on page 14 of this paper and include both an attached replacement sheet and an annotated sheet showing changes.

Remarks/Arguments begin on page 15 of this paper.

An **Appendix** including 14 pages of replacements sheets and 14 pages of annotated sheets is attached following page 21 of this paper.